Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,762	LI ET AL.	
Examiner	Art Unit	
Hanh Nguyen	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
375	240.11	8/21/2006	HN	
	240.1			
	240.15			
	240.21			
	240.12			
	240.08			
375	240			
370	235			
	229			
	230			
	236			
370	238			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			7.1		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
East		8/21/2006	HN